

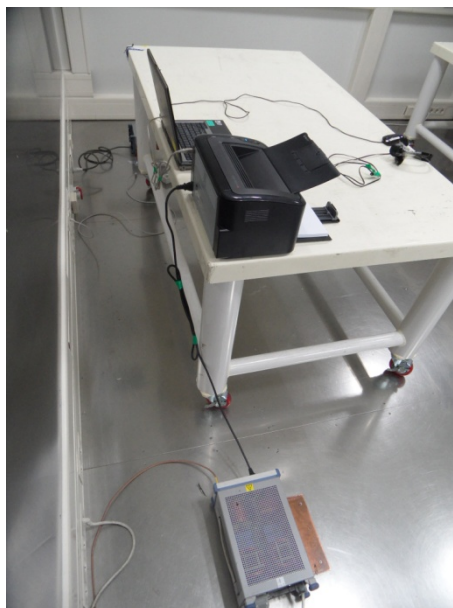
4.1.2 Temperature and humidity condition

Test date	October 12, 2010	Test engineer	Sung Jin Sim
Test place	Shielded Room #1		

4.1.3 Photograph of Test Setup



Front

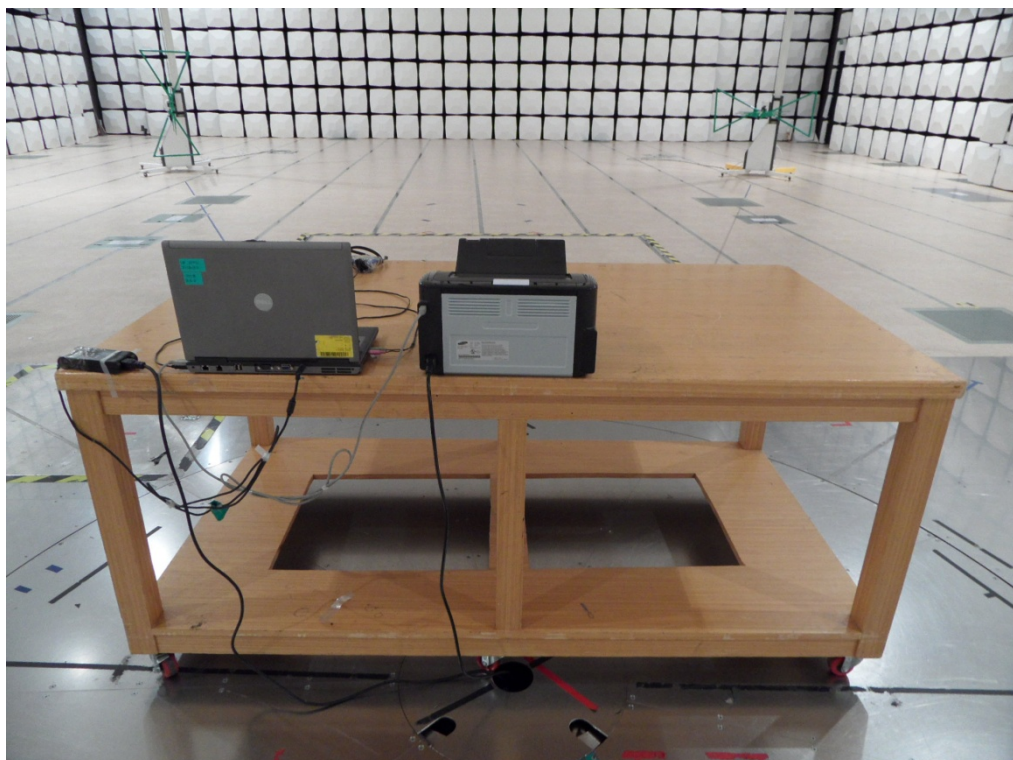


Rear

4.2.3 Photograph of Test Setup



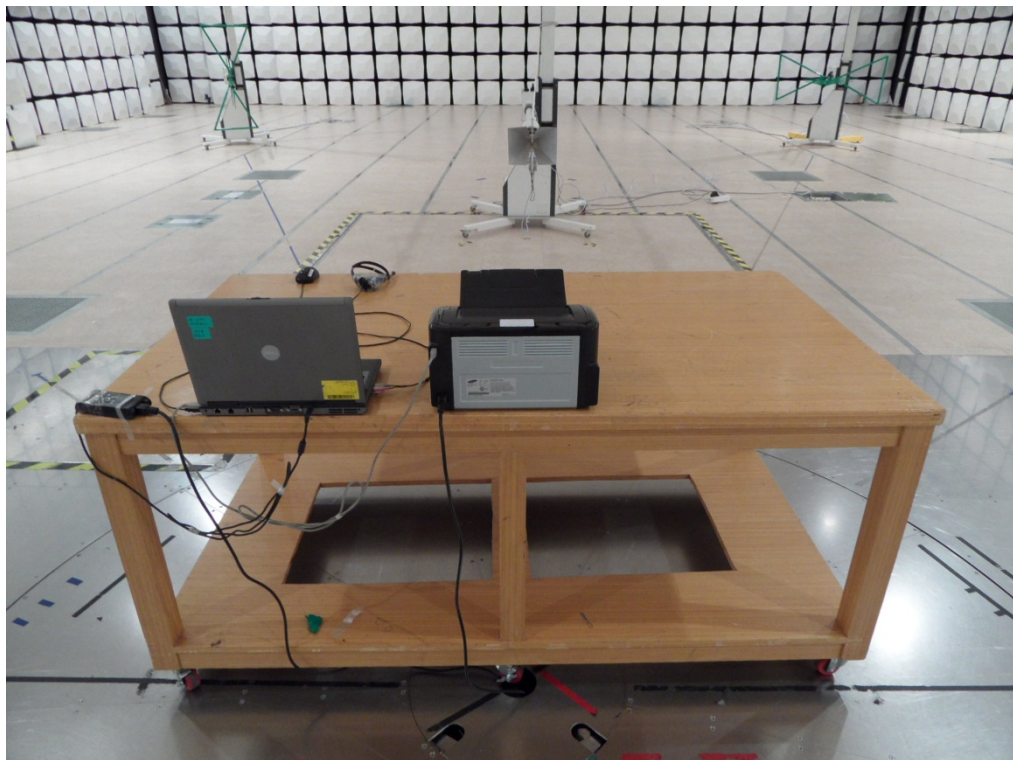
Front



Rear



Front (above 1GHz)



Rear (above 1GHz)